

LTC2175-14/ LTC2174-14/LTC2173-14

14-Bit, 125Msps/105Msps/ 80Msps Low Power Quad ADCs

FEATURES

- 4-Channel Simultaneous Sampling ADC
- **73.1dB SNR**
- 88dB SFDR
- Low Power: 558mW/450mW/376mW Total. 140mW/113mW/94mW per Channel
- Single 1.8V Supply
- Serial LVDS Outputs: 1 or 2 Bits per Channel
- Selectable Input Ranges: 1V_{P-P} to 2V_{P-P}
- 800MHz Full Power Bandwidth S/H
- Shutdown and Nap Modes
- Serial SPI Port for Configuration
- Pin Compatible 14-Bit and 12-Bit Versions
- 52-Pin (7mm × 8mm) QFN Package

APPLICATIONS

- Communications
- Cellular Base Stations
- Software Defined Radios
- Portable Medical Imaging
- Multichannel Data Acquisition
- Nondestructive Testing

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1 8V 1 8V LTC2175-14, 125Msps, OV_{DD} VDD 2-Tone FFT, f_{IN} = 70MHz and 75MHz CHANNEL 1 0 14-BIT OUT1A ANALOG S/H ADC CORE -10 OUT1B INPUT -20 CHANNEL 2 -30 OUT2A 14-BIT S/H ANAL OG ADC CORE (dBFS) -40 OUT2B INPUT DATA -50 SERIALIZER AMPLITUDE SERIALIZED CHANNEL 3 -60 OUT3A 14-BIT ANALOG S/H LVDS ADC CORE -70 OUT3B OUTPUTS INPUT -80 CHANNEL 4 OUT4A -90 14-BIT S/H ANALOG ADC CORE -100 OUT4B INPUT -110 DATA -120 CLOCK ENCODE 10 30 40 0 20 50 PLL OUT INPUT FREQUENCY (MHz) FRAME 217514 TA01

TYPICAL APPLICATION

DESCRIPTION

The LTC[®]2175-14/LTC2174-14/LTC2173-14 are 4-channel. simultaneous sampling 14-bit A/D converters designed for digitizing high frequency, wide dynamic range signals. They are perfect for demanding communications applications with AC performance that includes 73.1dB SNR and 88dB spurious free dynamic range (SFDR). Ultralow jitter of 0.15ps_{BMS} allows undersampling of IF frequencies with excellent noise performance.

DC specs include ±1LSB INL (typ), ±0.3LSB DNL (typ) and no missing codes over temperature. The transition noise is a low 1.2LSB_{BMS}.

The digital outputs are serial LVDS to minimize the number of data lines. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). The LVDS drivers have optional internal termination and adjustable output levels to ensure clean signal integrity.

The ENC⁺ and ENC⁻ inputs may be driven differentially or single-ended with a sine wave, PECL, LVDS, TTL, or CMOS inputs. An internal clock duty cycle stabilizer allows high performance at full speed for a wide range of clock duty cycles.

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217514 TA01b

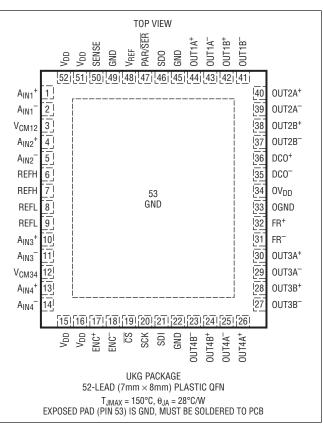


ABSOLUTE MAXIMUM RATINGS

(Notes 1, 2)

Supply Voltages
V _{DD} , 0V _{DD}
Analog Input Voltage (A _{IN} ⁺ , A _{IN} ⁻ ,
PAR/SER, SENSE) (Note 3) $-0.3V$ to (V _{DD} + 0.2V)
Digital Input Voltage (ENC+, ENC ⁻ , CS ,
SDI, SCK) (Note 4)0.3V to 3.9V
SDO (Note 4)0.3V to 3.9V
Digital Output Voltage $-0.3V$ to $(0V_{DD} + 0.3V)$
Operating Temperature Range
LTC2175C, 2174C, 2173C0°C to 70°C
LTC2175I, 2174I, 2173I–40°C to 85°C
Storage Temperature Range65°C to 150°C

PIN CONFIGURATIONS



ORDER INFORMATION

LEAD FREE FINISH	TAPE AND REEL	PART MARKING*	PACKAGE DESCRIPTION	TEMPERATURE RANGE
LTC2175CUKG-14#PBF	LTC2175CUKG-14#TRPBF	LTC2175UKG-14	52-Lead (7mm × 8mm) Plastic QFN	0°C to 70°C
LTC2175IUKG-14#PBF	LTC2175IUKG-14#TRPBF	LTC2175UKG-14	52-Lead (7mm × 8mm) Plastic QFN	–40°C to 85°C
LTC2174CUKG-14#PBF	LTC2174CUKG-14#TRPBF	LTC2174UKG-14	52-Lead (7mm × 8mm) Plastic QFN	0°C to 70°C
LTC2174IUKG-14#PBF	LTC2174IUKG-14#TRPBF	LTC2174UKG-14	52-Lead (7mm × 8mm) Plastic QFN	-40°C to 85°C
LTC2173CUKG-14#PBF	LTC2173CUKG-14#TRPBF	LTC2173UKG-14	52-Lead (7mm × 8mm) Plastic QFN	0°C to 70°C
LTC2173IUKG-14#PBF	LTC2173IUKG-14#TRPBF	LTC2173UKG-14	52-Lead (7mm × 8mm) Plastic QFN	-40°C to 85°C

Consult LTC Marketing for parts specified with wider operating temperature ranges. *The temperature grade is identified by a label on the shipping container. Consult LTC Marketing for information on non-standard lead based finish parts.

For more information on lead free part marking, go to: http://www.linear.com/leadfree/

For more information on tape and reel specifications, go to: http://www.linear.com/tapeandreel/





CONVERTER CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. (Note 5)

			L 1	C2175-	14	ា	C2174-	14	LT	C2173-*	14	
PARAMETER	CONDITIONS		MIN	ТҮР	MAX	MIN	ТҮР	MAX	MIN	ТҮР	MAX	UNITS
Resolution (No Missing Codes)		•	14			14			14			Bits
Integral Linearity Error	Differential Analog Input (Note 6)	•	-4.1	±1.2	4.1	-3.25	±1	3.25	-2.75	±1	2.75	LSB
Differential Linearity Error	Differential Analog Input	•	-0.9	±0.3	0.9	-0.8	±0.3	0.8	-0.8	±0.3	0.8	LSB
Offset Error	(Note 7)	•	-12	±3	12	-12	±3	12	-12	±3	12	mV
Gain Error	Internal Reference External Reference	•	-2.6	-1.3 -1.3	0	-2.6	-1.3 -1.3	0	-2.6	-1.3 -1.3	0	%FS %FS
Offset Drift				±20			±20			±20		μV/°C
Full-Scale Drift	Internal Reference External Reference			±35 ±25			±35 ±25			±35 ±25		ppm/°C ppm/°C
Gain Matching	External Reference			±0.2			±0.2			±0.2		%FS
Offset Matching				±3			±3			±3		mV
Transition Noise	External Reference			1.2			1.2			1.2		LSB _{RMS}

ANALOG INPUT The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
V _{IN}	Analog Input Range (A _{IN} ⁺ – A _{IN} ⁻)	1.7V < V _{DD} < 1.9V	٠		1 to 2		V _{P-P}
V _{IN(CM)}	Analog Input Common Mode $(A_{IN}^{+} + A_{IN}^{-})/2$	Differential Analog Input (Note 8)	٠	V _{CM} – 100mV	V _{CM}	V _{CM} + 100mV	V
V _{SENSE}	External Voltage Reference Applied to SENSE	External Reference Mode	٠	0.625	1.250	1.300	V
IINCM	Analog Input Common Mode Current	Per Pin, 125Msps Per Pin, 105Msps Per Pin, 80Msps			155 130 100		μΑ μΑ μΑ
I _{IN1}	Analog Input Leakage Current No Encode	$0 < A_{IN}^+, A_{IN}^- < V_{DD},$	٠	-1		1	μA
I _{IN2}	PAR/SER Input Leakage Current	0 < PAR/ SER < V _{DD}	٠	-3		3	μA
I _{IN3}	SENSE Input Leakage Current	0.625 < SENSE < 1.3V	٠	-6		6	μA
t _{AP}	Sample-and-Hold Acquisition Delay Time				0		ns
t _{JITTER}	Sample-and-Hold Acquisition Delay Jitter				0.15		ps _{RMS}
CMRR	Analog Input Common Mode Rejection Ratio				80		dB
BW-3B	Full-Power Bandwidth	Figure 6 Test Circuit			800		MHz



DYNAMIC ACCURACY otherwise specifications are at $T_A = 25^{\circ}$ C. $A_{IN} = -1$ dBFS. (Note 5)

				Ľ	C2175-	14	LI	C2174-	14	LT	C2173-1	14	
SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	MIN	ТҮР	MAX	MIN	TYP	MAX	UNITS
SNR	Signal-to-Noise Ratio	5MHz Input 70MHz Input 140MHz Input	•	71.1	73.1 73 72.6		70.7	73 72.9 72.6		70.9	73 72.9 72.5		dBFS dBFS dBFS
SFDR	Spurious Free Dynamic Range 2nd or 3rd Harmonic	5MHz Input 70MHz Input 140MHz Input	•	75	88 85 82		75	88 85 82		77	88 85 82		dBFS dBFS dBFS
	Spurious Free Dynamic Range 4th Harmonic or Higher	5MHz Input 70MHz Input 140MHz Input	•	84	90 90 90		84	90 90 90		85	90 90 90		dBFS dBFS dBFS
S/(N+D)	Signal-to-Noise Plus Distortion Ratio	5MHz Input 70MHz Input 140MHz Input	•	69.6	73 72.6 72		70.2	73 72.6 72		70.4	72.9 72.6 72		dBFS dBFS dBFS
	Crosstalk, Near Channel	10MHz Input (Note 12)			-90			-90			-90		dBc
	Crosstalk, Far Channel	10MHz Input (Note 12)			-105			-105			-105		dBc

INTERNAL REFERENCE CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. A_{IN} = -1dBFS. (Note 5)

PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
V _{CM} Output Voltage	$I_{OUT} = 0$	0.5 • V _{DD} – 25m	V 0.5 • V _{DD}	0.5 • V _{DD} + 25mV	V
V _{CM} Output Temperature Drift			±25		ppm/°C
V _{CM} Output Resistance	–600μA < I _{OUT} < 1mA		4		Ω
V _{REF} Output Voltage	$I_{OUT} = 0$	1.225	1.250	1.275	V
V _{REF} Output Temperature Drift			±25		ppm/°C
V _{REF} Output Resistance	-400μA < I _{OUT} < 1mA		7		Ω
V _{REF} Line Regulation	1.7V < V _{DD} < 1.9V		0.6		mV/V





DIGITAL INPUTS AND OUTPUTS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
ENCODE	INPUTS (ENC ⁺ , ENC ⁻)						
Different	tial Encode Mode (ENC ⁻ Not Tied to GND)						
V _{ID}	Differential Input Voltage	(Note 8)		0.2			V
VICM	Common Mode Input Voltage	Internally Set Externally Set (Note 8)	•	1.1	1.2	1.6	V
VIN	Input Voltage Range	ENC ⁺ , ENC ⁻ to GND		0.2		3.6	V
R _{IN}	Input Resistance	(See Figure 10)			10		kΩ
CIN	Input Capacitance				3.5		pF
Single-E	nded Encode Mode (ENC ⁻ Tied to GND)						
VIH	High Level Input Voltage	V _{DD} = 1.8V		1.2			V
VIL	Low Level Input Voltage	V _{DD} = 1.8V				0.6	V
VIN	Input Voltage Range	ENC ⁺ to GND		0		3.6	V
R _{IN}	Input Resistance	(See Figure 11)			30		kΩ
CIN	Input Capacitance				3.5		pF
DIGITAL	INPUTS (\overline{CS} , SDI, SCK in Serial or Paralle	l Programming Mode. SDO in Parallel Progra	amminç	y Mode)			
V _{IH}	High Level Input Voltage	V _{DD} = 1.8V		1.3			V
V _{IL}	Low Level Input Voltage	V _{DD} = 1.8V				0.6	V
I _{IN}	Input Current	V _{IN} = 0V to 3.6V		-10		10	μA
CIN	Input Capacitance				3		pF
SDO OU	TPUT (Serial Programming Mode. Open-D	rain Output. Requires 2k Ω Pull-Up Resistor i	f SDO is	s Used)			
R _{OL}	Logic Low Output Resistance to GND	V _{DD} = 1.8V, SDO = 0V			200		Ω
I _{OH}	Logic High Output Leakage Current	SDO = 0V to 3.6V		-10		10	μA
C _{OUT}	Output Capacitance				3		pF
DIGITAL	DATA OUTPUTS						
V _{OD}	Differential Output Voltage	100Ω Differential Load, 3.5mA Mode 100Ω Differential Load, 1.75mA Mode	•	247 125	350 175	454 250	mV mV
V _{OS}	Common Mode Output Voltage	100Ω Differential Load, 3.5mA Mode 100Ω Differential Load, 1.75mA Mode	•	1.125 1.125	1.250 1.250	1.375 1.375	V V
R _{TERM}	On-Chip Termination Resistance	Termination Enabled, OV _{DD} = 1.8V			100		Ω

POWER REQUIREMENTS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. (Note 9)

LTC2175-14 LTC2174-14 LTC2173-14 PARAMETER SYMBOL CONDITIONS MIN TYP MAX MIN TYP MAX MIN TYP MAX UNITS V V_{DD} Analog Supply Voltage (Note 10) 1.7 1.8 1.9 1.7 1.9 1.7 1.8 1.9 1.8 V 1.7 1.9 1.7 1.9 1.7 1.9 OVDD **Output Supply Voltage** (Note 10) 1.8 1.8 1.8 Analog Supply Current Sine Wave Input 283 305 224 243 184 200 mΑ I_{VDD} **Digital Supply Current** 2-Lane Mode, 1.75mA Mode 27 26 31 25 29 • 31 mΑ lovdd 2-Lane Mode, 3.5mA Mode 49 48 53 47 52 54 mΑ P_{DISS} **Power Dissipation** 2-Lane Mode, 1.75mA Mode 558 605 450 493 376 412 mW 2-Lane Mode, 3.5mA Mode 598 646 490 533 416 454 mW Sleep Mode Power 1 1 mW PSLEEP 1 P_{NAP} Nap Mode Power 85 85 85 mW Power Increase With Differential Encode Mode Enabled 20 20 20 PDIFFCLK mW (No Increase for Sleep Mode)

TIMING CHARACTERISTICS The • denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$. (Note 5)

				Ľ	C2175-	14	LI	C2174-	14	LT	C2173-	14	
SYMBOL	PARAMETER	CONDITIONS		MIN	TYP	MAX	MIN	ТҮР	MAX	MIN	ТҮР	MAX	UNITS
f _S	Sampling Frequency	(Notes 10,11)	•	5		125	5		105	5		80	MHz
t _{ENCL}	ENC Low Time (Note 8)	Duty Cycle Stabilizer Off Duty Cycle Stabilizer On	•	3.8 2	4 4	100 100	4.52 2	4.76 4.76	100 100	5.93 2	6.25 6.25	100 100	ns ns
t _{ENCH}	ENC High Time (Note 8)	Duty Cycle Stabilizer Off Duty Cycle Stabilizer On	•	3.8 2	4 4	100 100	4.52 2	4.76 4.76	100 100	5.93 2	6.25 6.25	100 100	ns ns
t _{AP}	Sample-and-Hold Acquisition Delay Time				0			0			0		ns

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
Digital Da	ita Outputs ($R_{TERM} = 100\Omega$ Diff	ferential, $C_L = 2pF$ to GND on Each Output)					
t _{SER}	Serial Data Bit Period	2-Lanes, 16-Bit Serialization 2-Lanes, 14-Bit Serialization 2-Lanes, 12-Bit Serialization 1-Lane, 16-Bit Serialization 1-Lane, 14-Bit Serialization 1-Lane, 12-Bit Serialization			$\begin{array}{c} 1/(8 \bullet f_{S}) \\ 1/(7 \bullet f_{S}) \\ 1/(6 \bullet f_{S}) \\ 1/(16 \bullet f_{S}) \\ 1/(14 \bullet f_{S}) \\ 1/(12 \bullet f_{S}) \\ 1/(12 \bullet f_{S}) \end{array}$		S S S S S
t _{FRAME}	FR to DCO Delay	(Note 8)	•	0.35 • t _{SER}	0.5 • t _{SER}	0.65 • t _{SER}	S
t _{DATA}	DATA to DCO Delay	(Note 8)	•	0.35 • t _{SER}	0.5 • t _{SER}	0.65 • t _{SER}	S
t _{PD}	Propagation Delay	(Note 8)	•	0.7n + 2 • t _{SER}	1.1n + 2 • t _{SER}	1.5n + 2 • t _{SER}	S
t _R	Output Rise Time	Data, DCO, FR, 20% to 80%			0.17		ns
t _F	Output Fall Time	Data, DCO, FR, 20% to 80%			0.17		ns
	DCO Cycle-Cycle Jitter	t _{SER} = 1ns			60		ps _{P-P}
	Pipeline Latency				6		Cycles



TIMING CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_A = 25°C. (Note 5)

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
SPI Port T	Timing (Note 8)						
t _{SCK}	SCK Period	Write Mode Readback Mode, C _{SDO} = 20pF, R _{PULLUP} = 2k	•	40 250			ns
t _S	CS to SCK Setup Time			5			ns
t _H	SCK to CS Setup Time		•	5			ns
t _{DS}	SDI Setup Time			5			ns
t _{DH}	SDI Hold Time			5			ns
t _{DO}	SCK Falling to SDO Valid	Readback Mode, C _{SDO} = 20pF, R _{PULLUP} = 2k	•			125	ns

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: All voltage values are with respect to GND with GND and OGND shorted (unless otherwise noted).

Note 3: When these pin voltages are taken below GND or above V_{DD} , they will be clamped by internal diodes. This product can handle input currents of greater than 100mA below GND or above V_{DD} without latchup.

Note 4: When these pin voltages are taken below GND they will be clamped by internal diodes. When these pin voltages are taken above V_{DD} they will not be clamped by internal diodes. This product can handle input currents of greater than 100mA below GND without latchup.

Note 5: $V_{DD} = 0V_{DD} = 1.8V$, $f_{SAMPLE} = 125MHz$ (LTC2175), 105MHz (LTC2174), or 80MHz (LTC2173), 2-lane output mode, differential ENC⁺/ ENC⁻ = $2V_{P-P}$ sine wave, input range = $2V_{P-P}$ with differential drive, unless otherwise noted.

Note 6: Integral nonlinearity is defined as the deviation of a code from a best fit straight line to the transfer curve. The deviation is measured from the center of the quantization band.

Note 7: Offset error is the offset voltage measured from -0.5 LSB when the output code flickers between 00 0000 0000 0000 and 11 1111 1111 1111 in 2's complement output mode.

Note 8: Guaranteed by design, not subject to test.

Note 9: $V_{DD} = 0V_{DD} = 1.8V$, $f_{SAMPLE} = 125MHz$ (LTC2175), 105MHz (LTC2174), or 80MHz (LTC2173), 2-lane output mode, ENC⁺ = singleended 1.8V square wave, ENC⁻ = 0V, input range = $2V_{P-P}$ with differential drive, unless otherwise noted. The supply current and power dissipation specifications are totals for the entire chip, not per channel.

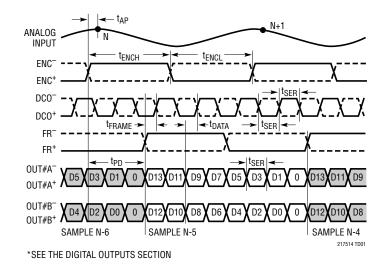
Note 10: Recommended operating conditions.

Note 11: The maximum sampling frequency depends on the speed grade of the part and also which serialization mode is used. The maximum serial data rate is 1000Mbps so t_{SER} must be greater than or equal to 1ns.

Note 12: Near-channel crosstalk refers to Ch. 1 to Ch.2, and Ch.3 to Ch.4. Far-channel crosstalk refers to Ch.1 to Ch.3, Ch.1 to Ch.4, Ch.2 to Ch.3, and Ch.2 to Ch.4.

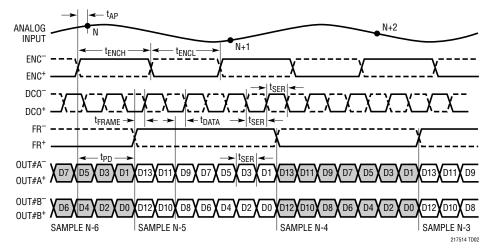


TIMING DIAGRAMS



2-Lane Output Mode, 16-Bit Serialization*

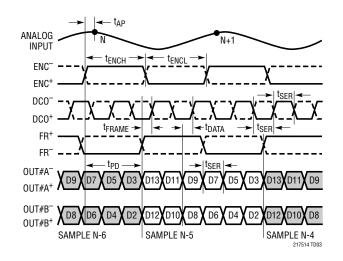
2-Lane Output Mode, 14-Bit Serialization



NOTE THAT IN THIS MODE FR⁺/FR⁻ HAS TWO TIMES THE PERIOD OF ENC⁺/ENC⁻

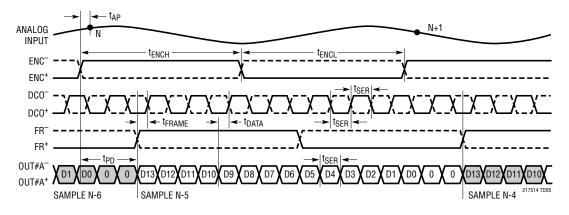


TIMING DIAGRAMS



2-Lane Output Mode, 12-Bit Serialization

1-Lane Output Mode, 16-Bit Serialization

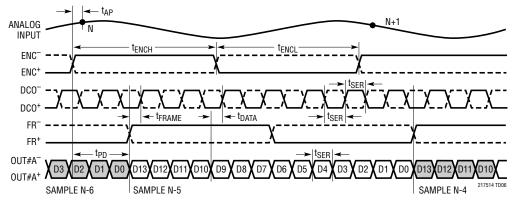


OUT#B⁺, OUT#B⁻ ARE DISABLED



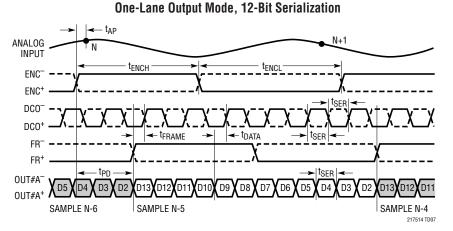
LTC2175-14/ LTC2174-14/LTC2173-14

TIMING DIAGRAMS



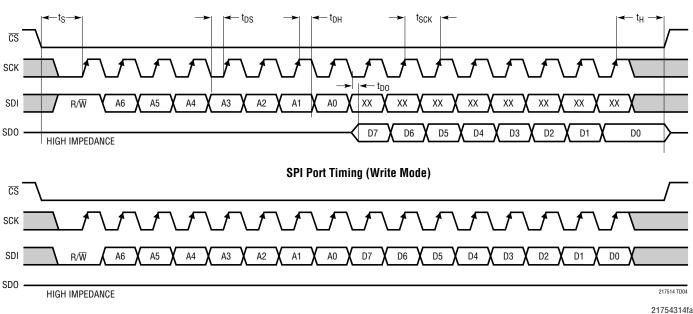
One-Lane Output Mode, 14-Bit Serialization

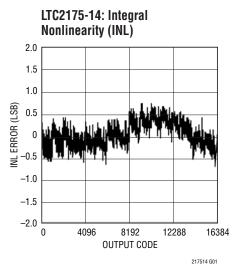
OUT#B⁺, OUT#B⁻ ARE DISABLED

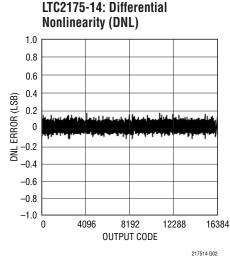


OUT#B⁺, OUT#B⁻ ARE DISABLED

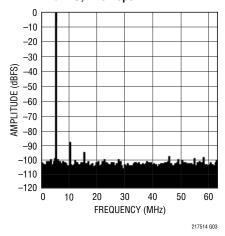




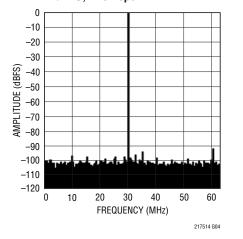




LTC2175-14: 8k Point FFT, $f_{IN} = 5MHz$ -1dBFS, 125Msps



LTC2175-14: 8k Point FFT, f_{IN} = 30MHz -1dBFS, 125Msps



LTC2175-14: 8k Point 2-Tone FFT,

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FREQUENCY (MHz)

40

50

60

217514 G07

20

 $f_{IN} = 70MHz$, 75MHz, -1dBFS,

125Msps

0

-10

-20

-30

-40

-50

-60

-70

-80

-90

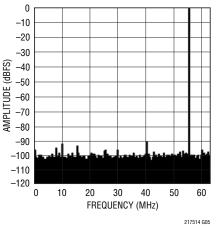
-100

-110 -120

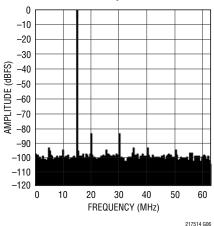
0 10

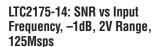
AMPLITUDE (dBFS)

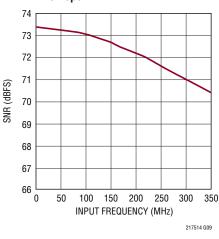
LTC2175-14: 8k Point FFT, f_{IN} = 70MHz -1dBFS, 125Msps



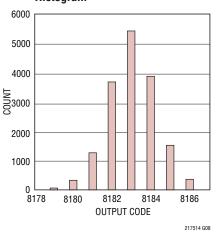




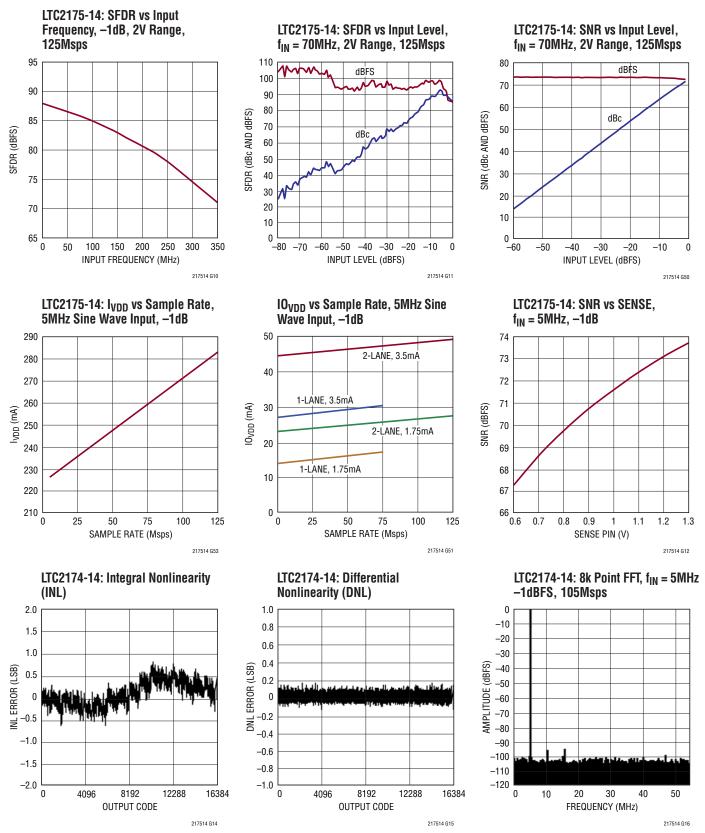




LTC2175-14: Shorted Input Histogram

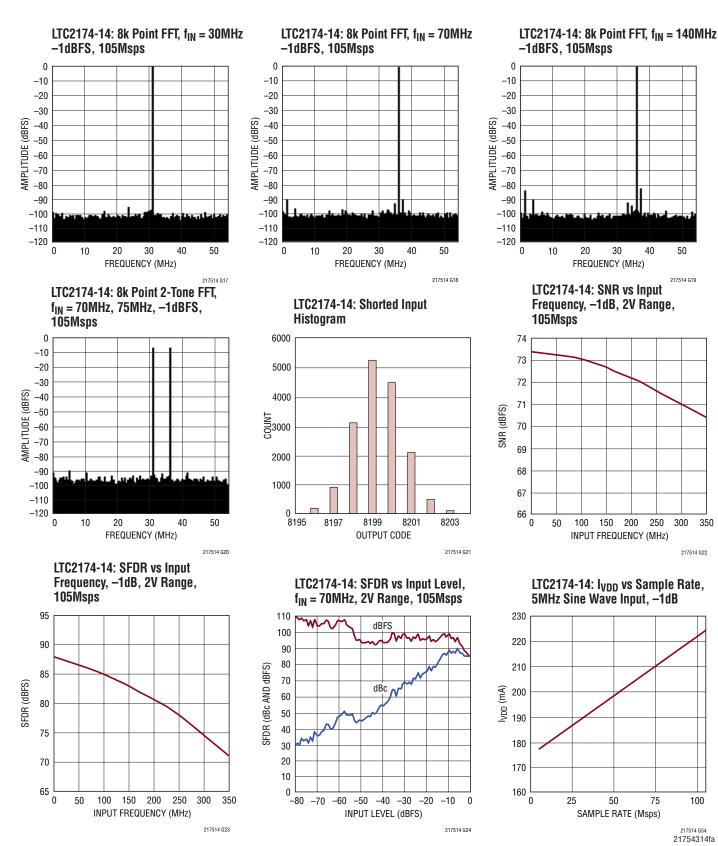




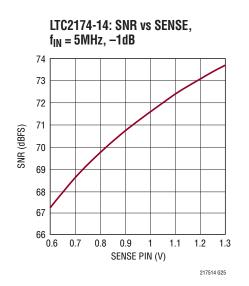


²¹⁷⁵⁴³¹⁴fa

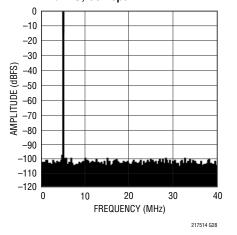






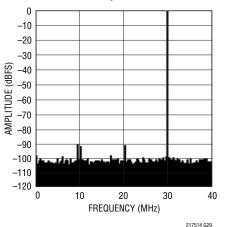


LTC2173-14: 8k Point FFT, $f_{IN} = 5MHz$ -1dBFS, 80Msps

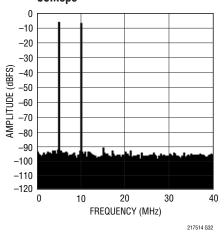


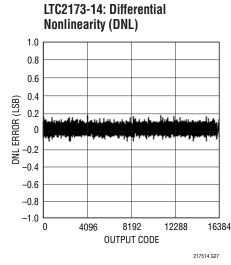
LTC2173-14: Integral Nonlinearity (INL) 2.0 1.5 1.0 INL ERROR (LSB) 0.5 0 -0.5 -1.0 -1.5 -2.0 0 4096 8192 16384 12288 OUTPUT CODE 217514 G26

LTC2173-14: 8k Point FFT, f_{IN} = 30MHz -1dBFS, 80Msps

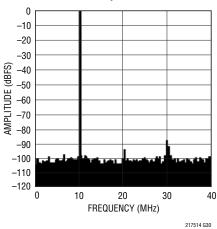


LTC2173-14: 8k Point 2-Tone FFT, $f_{IN} = 70MHz$, 75MHz, -1dBFS, 80Msps

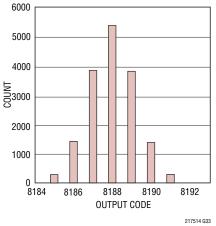




LTC2173-14: 8k Point FFT, $f_{IN} = 70MHz$ -1dBFS, 80Msps



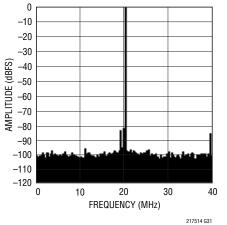
LTC2173-14: Shorted Input Histogram



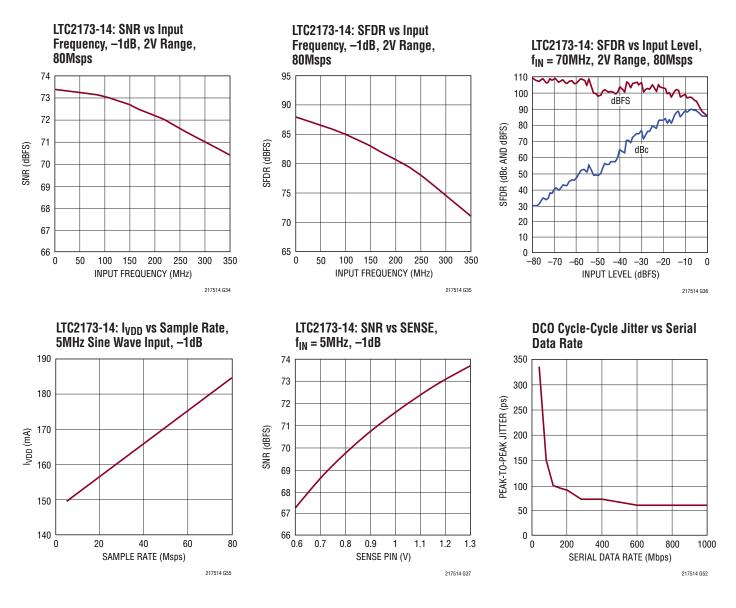
217514 G33 21754314fa



LTC2173-14: 8k Point FFT, f_{IN} = 140MHz -1dBFS, 80Msps







PIN FUNCTIONS

A_{IN1}⁺ (Pin 1): Channel 1 Positive Differential Analog Input.

A_{IN1}⁻ (Pin 2): Channel 1 Negative Differential Analog Input.

 V_{CM12} (Pin 3): Common Mode Bias Output, Nominally Equal to $V_{DD}/2$. V_{CM} should be used to bias the common mode of the analog inputs of channels 1 and 2. Bypass to ground with a 0.1µF ceramic capacitor.

A_{IN2}⁺ (Pin 4): Channel 2 Positive Differential Analog Input.

A_{IN2}⁻ (Pin 5): Channel 2 Negative Differential Analog Input.

REFH (Pins 6,7): ADC High Reference. Bypass to pins 8, 9 with a 2.2μ F ceramic capacitor and to ground with a 0.1μ F ceramic capacitor.

REFL (Pins 8,9): ADC Low Reference. Bypass to pins 6, 7 with a 2.2μ F ceramic capacitor and to ground with a 0.1μ F ceramic capacitor.

AIN3⁺ (Pin 10): Channel 3 Positive Differential Analog Input.

AIN3⁻ (Pin 11): Channel 3 Negative Differential Analog Input.

 V_{CM34} (Pin 12): Common Mode Bias Output, Nominally Equal to $V_{DD}/2$. V_{CM} should be used to bias the common mode of the analog inputs of channels 3 and 4. Bypass to ground with a 0.1µF ceramic capacitor.

AIN4⁺ (Pin 13): Channel 4 Positive Differential Analog Input.

AIN4⁻ (Pin 14): Channel 4 Negative Differential Analog Input.

V_{DD} (**Pins 15, 16, 51, 52**): 1.8V Analog Power Supply. Bypass to ground with 0.1µF ceramic capacitors. Adjacent pins can share a bypass capacitor.

ENC⁺ (Pin 17): Encode Input. Conversion starts on the rising edge.

ENC⁻ (Pin 18): Encode Complement Input. Conversion starts on the falling edge.

CS (Pin 19): In serial programming mode, (PAR/ \overline{SER} = 0V), \overline{CS} is the serial interface chip select input. When \overline{CS} is low, SCK is enabled for shifting data on SDI into the mode control registers. In the parallel programming mode (PAR/ $\overline{SER} = V_{DD}$), \overline{CS} selects 2-lane or 1-lane output mode. \overline{CS} can be driven with 1.8V to 3.3V logic.

SCK (Pin 20): In serial programming mode, (PAR/ $\overline{\text{SER}}$ = 0V), SCK is the serial interface clock input. In the parallel programming mode (PAR/ $\overline{\text{SER}}$ = V_{DD}), SCK selects 3.5mA or 1.75mA LVDS output currents. SCK can be driven with 1.8V to 3.3V logic.

SDI (Pin 21): In serial programming mode, (PAR/ $\overline{\text{SER}}$ = 0V), SDI is the serial interface data Input. Data on SDI is clocked into the mode control registers on the rising edge of SCK. In the parallel programming mode (PAR/ $\overline{\text{SER}}$ = V_{DD}), SDI can be used to power down the part. SDI can be driven with 1.8V to 3.3V logic.

GND (Pins 22, 45, 49): ADC Power Ground.

OGND (Pin 33): Output Driver Ground. Must be shorted to the ground plane by a very low inductance path. Use multiple vias close to the pin.

 OV_{DD} (Pin 34): Output Driver Supply. Bypass to ground with a 0.1µF ceramic capacitor.

SDO (Pin 46): In serial programming mode, (PAR/SER = 0V), SDO is the optional serial interface data output. Data on SDO is read back from the mode control registers and can be latched on the falling edge of SCK. SDO is an open-drain NMOS output that requires an external 2k pull-up resistor to 1.8V - 3.3V. If read back from the mode control registers is not needed, the pull-up resistor is not necessary and SDO can be left unconnected. In the parallel programming mode (PAR/SER = V_{DD}), SDO is an input that enables internal 100Ω termination resistors on the digital outputs. When used as an input, SDO can be driven with 1.8V to 3.3V logic through a 1k series resistor.

PAR/SER (Pin 47): Programming Mode Selection Pin. Connect to ground to enable the serial programming mode. \overline{CS} , SCK, SDI, SDO become a serial interface that control the A/D operating modes. Connect to V_{DD} to enable the parallel programming mode where \overline{CS} , SCK, SDI, SDO become parallel logic inputs that control a reduced set of the A/D operating modes. PAR/SER should be connected directly to ground or the V_{DD} of the part and not be driven by a logic signal.

 V_{REF} (Pin 48): Reference Voltage Output. Bypass to ground with a 1µF ceramic capacitor, nominally 1.25V.



PIN FUNCTIONS

SENSE (Pin 50): Reference Programming Pin. Connecting SENSE to V_{DD} selects the internal reference and a ± 1 V input range. Connecting SENSE to ground selects the internal reference and a ± 0.5 V input range. An external reference between 0.625V and 1.3V applied to SENSE selects an input range of $\pm 0.8 \cdot V_{SENSE}$.

Exposed Pad (Pin 53): Ground. The Exposed Pad must be soldered to the PCB ground.

LVDS Outputs

All pins in this section are differential LVDS outputs. The output current level is programmable. There is an optional internal 100Ω termination resistor between the pins of each LVDS output pair.

OUT4B⁻/OUT4B⁺, OUT4A⁻/OUT4A⁺ (Pins 23/24, 25/26): Serial data outputs for Channel 4. In 1-lane output mode only OUT4A⁻/OUT4A⁺ are used.

OUT3B⁻/OUT3B⁺, OUT3A⁻/OUT3A⁺ (Pins 27/28, 29/30):

Serial data outputs for Channel 3. In 1-lane output mode only OUT3A⁻/OUT3A⁺ are used.

FR⁻/FR⁺ (Pins 31/32): Frame Start Outputs.

DCO⁻/DCO⁺ (Pins 35/36): Data Clock Outputs.

OUT2B⁻/OUT2B⁺, OUT2A⁻/OUT2A⁺ (Pins 37/38, 39/40): Serial data outputs for Channel 2. In 1-lane output mode only OUT2A⁻/OUT2A⁺ are used.

OUT1B⁻/OUT1B⁺, OUT1A⁻/OUT1A⁺ (Pins 41/42, 43/44): Serial data outputs for Channel 1. In 1-lane output mode only OUT1A⁻/OUT1A⁺ are used.

FUNCTIONAL BLOCK DIAGRAM

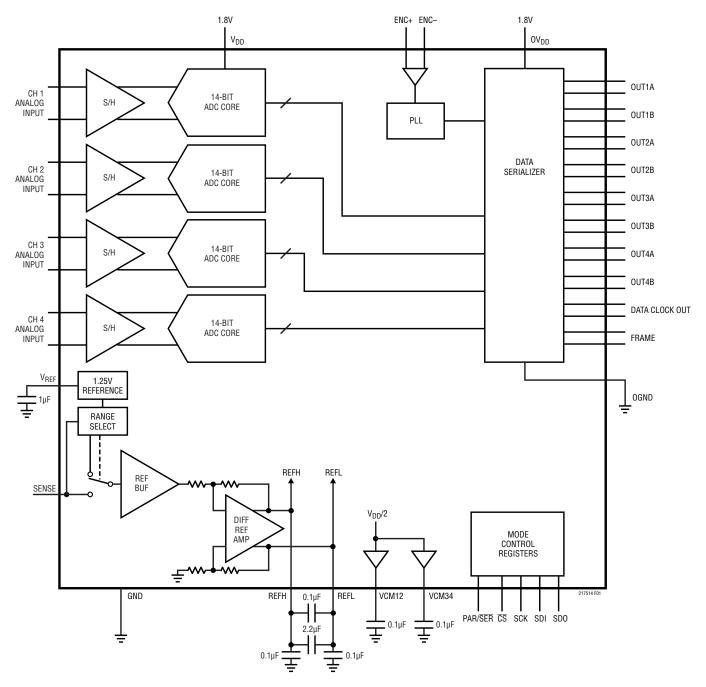


Figure 1. Functional Block Diagram



CONVERTER OPERATION

The LTC2175-14/LTC2174-14/LTC2173-14 are low power, 4-channel, 14-bit, 125Msps/105Msps/80Msps A/D converters that are powered by a single 1.8V supply. The analog inputs should be driven differentially. The encode input can be driven differentially for optimal jitter performance, or single-ended for lower power consumption. The digital outputs are serial LVDS to minimize the number of data lines. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). Many additional features can be chosen by programming the mode control registers through a serial SPI port.

ANALOG INPUT

The analog inputs are differential CMOS sample-and-hold circuits (Figure 2). The inputs should be driven differentially around a common mode voltage set by the V_{CM12} or V_{CM34} output pins, which are nominally $V_{DD}/2$. For the

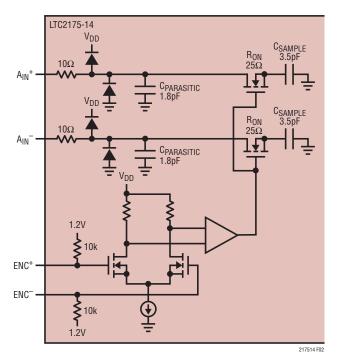


Figure 2. Equivalent Input Circuit. Only One of the Four Analog Channels is Shown. 2V input range, the inputs should swing from V_{CM} – 0.5V to V_{CM} + 0.5V. There should be 180° phase difference between the inputs.

The four channels are simultaneously sampled by a shared encode circuit (Figure 2).

INPUT DRIVE CIRCUITS

Input Filtering

If possible, there should be an RC low pass filter right at the analog inputs. This lowpass filter isolates the drive circuitry from the A/D sample-and-hold switching, and also limits wideband noise from the drive circuitry. Figure 3 shows an example of an input RC filter. The RC component values should be chosen based on the application's input frequency.

Transformer Coupled Circuits

Figure 3 shows the analog input being driven by an RF transformer with a center-tapped secondary. The center

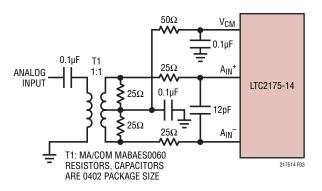


Figure 3. Analog Input Circuit Using a Transformer. Recommended for Input Frequencies from 5MHz to 70MHz.



tap is biased with V_{CM} , setting the A/D input at its optimal DC level. At higher input frequencies a transmission line balun transformer (Figures 4 to 6) has better balance, resulting in lower A/D distortion.

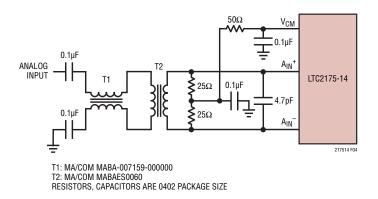
Amplifier Circuits

Figure 7 shows the analog input being driven by a high speed differential amplifier. The output of the amplifier is AC-coupled to the A/D so the amplifier's output common mode voltage can be optimally set to minimize distortion.

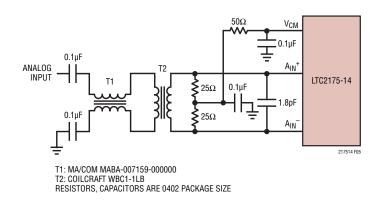
At very high frequencies an RF gain block will often have lower distortion than a differential amplifier. If the gain block is single-ended, then a transformer circuit (Figures 4 to 6) should convert the signal to differential before driving the A/D.

Reference

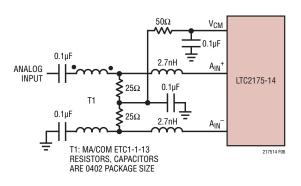
The LTC2175-14/LTC2174-14/LTC2173-14 has an internal 1.25V voltage reference. For a 2V input range using the internal reference, connect SENSE to V_{DD} . For a 1V input range using the internal reference, connect SENSE to













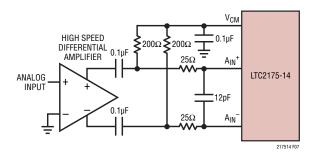


Figure 7. Front End Circuit Using a High Speed Differential Amplifier



ground. For a 2V input range with an external reference, apply a 1.25V reference voltage to SENSE (Figure 9).

The input range can be adjusted by applying a voltage to SENSE that is between 0.625V and 1.30V. The input range will then be $1.6 \cdot V_{SENSE}$.

The reference is shared by all four ADC channels, so it is not possible to independently adjust the input range of individual channels.

The $V_{REF},\ REFH$ and REFL pins should be bypassed as shown in Figure 8. The $0.1\mu F$ capacitor between REFH

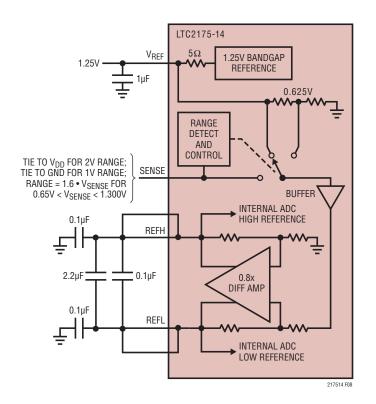


Figure 8. Reference Circuit

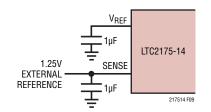
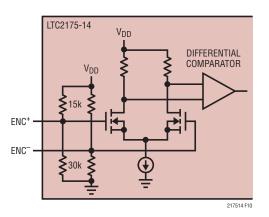


Figure 9. Using an External 1.25V Reference

and REFL should be as close to the pins as possible (not on the backside of the circuit board).

Encode Input

The signal quality of the encode inputs strongly affects the A/D noise performance. The encode inputs should be treated as analog signals—do not route them next to digital traces on the circuit board. There are two modes of operation for the encode inputs: the differential encode mode (Figure 10), and the single-ended encode mode (Figure 11).





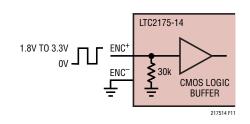


Figure 11. Equivalent Encode Input Circuit for Single-Ended Encode Mode

The differential encode mode is recommended for sinusoidal, PECL, or LVDS encode inputs (Figures 12 and 13). The encode inputs are internally biased to 1.2V through 10k equivalent resistance. The encode inputs can be taken above V_{DD} (up to 3.6V), and the common mode range is from 1.1V to 1.6V. In the differential encode mode, ENC⁻ should stay at least 200mV above ground to avoid falsely triggering the single-ended encode mode. For good jitter performance ENC⁺ should have fast rise and fall times.

The single-ended encode mode should be used with CMOS encode inputs. To select this mode, ENC^- is connected to ground and ENC^+ is driven with a square wave encode input. ENC^+ can be taken above V_{DD} (up to 3.6V) so 1.8V to 3.3V CMOS logic levels can be used. The ENC⁺ threshold

is 0.9V. For good jitter performance ENC⁺ should have fast rise and fall times.

Clock PLL and Duty Cycle Stabilizer

The encode clock is multiplied by an internal phase-locked loop (PLL) to generate the serial digital output data. If the encode signal changes frequency or is turned off, the PLL requires $25\mu s$ to lock onto the input clock.

A clock duty cycle stabilizer circuit allows the duty cycle of the applied encode signal to vary from 30% to 70%. In the serial programming mode it is possible to disable the duty cycle stabilizer, but this is not recommended. In the parallel programming mode the duty cycle stabilizer is always enabled.

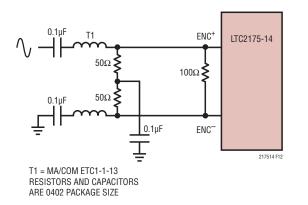


Figure 12. Sinusoidal Encode Drive

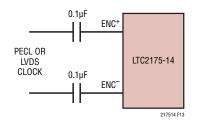


Figure 13. PECL or LVDS Encode Drive





DIGITAL OUTPUTS

The digital outputs of the LTC2175-14/LTC2174-14/ LTC2173-14 are serialized LVDS signals. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). The data can be serialized with 16, 14, or 12-bit serialization (see timing diagrams for details). Note that with 12-bit serialization the two LSBs are not available this mode is included for compatibility with the 12-bit versions of these parts.

The output data should be latched on the rising and falling edges of the data clock out (DCO). A data frame output (FR) can be used to determine when the data from a new conversion result begins. In the 2-lane, 14-bit serialization mode, the frequency of the FR output is halved.

The maximum serial data rate for the data outputs is 1Gbps, so the maximum sample rate of the ADC will depend on the serialization mode as well as the speed grade of the ADC (see Table 1). The minimum sample rate for all serialization modes is 5Msps.

By default the outputs are standard LVDS levels: 3.5mA output current and a 1.25V output common mode voltage. An external 100Ω differential termination resistor is required for each LVDS output pair. The termination

resistors should be located as close as possible to the LVDS receiver.

The outputs are powered by OV_{DD} and OGND which are isolated from the A/D core power and ground.

Programmable LVDS Output Current

The default output driver current is 3.5mA. This current can be adjusted by control register A2 in the serial programming mode. Available current levels are 1.75mA, 2.1mA, 2.5mA, 3mA, 3.5mA, 4mA and 4.5mA. In the parallel programming mode the SCK pin can select either 3.5mA or 1.75mA.

Optional LVDS Driver Internal Termination

In most cases using just an external 100Ω termination resistor will give excellent LVDS signal integrity. In addition, an optional internal 100Ω termination resistor can be enabled by serially programming mode control register A2. The internal termination helps absorb any reflections caused by imperfect termination at the receiver. When the internal termination is enabled, the output driver current is doubled to maintain the same output voltage swing. In the parallel programming mode the SDO pin enables internal termination. Internal termination should only be used with 1.75mA, 2.1mA or 2.5mA LVDS output current modes.

SERIALIZAT	ION MODE	MAXIMUM SAMPLING FREQUENCY, f _s (MHz)	DCO FREQUENCY	FR FREQUENCY	SERIAL DATA RATE
2-Lane	16-Bit Serialization	125	4 ∙ f _S	f _S	8 • f _S
2-Lane	14-Bit Serialization	125	3.5 • f _S	0.5 • f _S	7 • f _S
2-Lane	12-Bit Serialization	125	3 • f _S	f _S	6 • f _S
1-Lane	16-Bit Serialization	62.5	8 • f _S	f _S	16 • f _S
1-Lane	14-Bit Serialization	71.4	7 • f _S	f _S	14 • f _S
1-Lane	12-Bit Serialization	83.3	6 • f _S	f _S	12 • f _S

Table 1. Maximum Sampling Frequency for All Serialization Modes. Note That These Limits Are for the LTC2175-14. The Sampling Frequency for the Slower Speed Grades Cannot Exceed 105MHz (LTC2174-14) or 80MHz (LTC2173-14).



DATA FORMAT

Table 2 shows the relationship between the analog input voltage and the digital data output bits. By default the output data format is offset binary. The 2's complement format can be selected by serially programming mode control register A1.

A _{IN} + – A _{IN} [–] (2V RANGE)	D13-D0 (OFFSET BINARY)	D13-D0 (2's COMPLEMENT)
>1.000000V	11 1111 1111 1111	01 1111 1111 1111
+0.999878V	11 1111 1111 1111	01 1111 1111 1111
+0.999756V	11 1111 1111 1110	01 1111 1111 1110
+0.000122V	10 0000 0000 0001	00 0000 0000 0001
+0.000000V	10 0000 0000 0000	00 0000 0000 0000
-0.000122V	01 1111 1111 1111	11 1111 1111 1111
-0.000244V	01 1111 1111 1110	11 1111 1111 1110
-0.999878V	00 0000 0000 0001	10 0000 0000 0001
-1.000000V	00 0000 0000 0000	10 0000 0000 0000
<-1.000000V	00 0000 0000 0000	10 0000 0000 0000

Table 2. Output Codes vs Input Voltage

Digital Output Randomizer

Interference from the A/D digital outputs is sometimes unavoidable. Digital interference may be from capacitive or inductive coupling or coupling through the ground plane. Even a tiny coupling factor can cause unwanted tones in the ADC output spectrum. By randomizing the digital output before it is transmitted off chip, these unwanted tones can be randomized which reduces the unwanted tone amplitude.

The digital output is *randomized* by applying an exclusive-OR logic operation between the LSB and all other data output bits. To decode, the reverse operation is applied —an exclusive-OR operation is applied between the LSB and all other bits. The FR and DCO outputs are not affected. The output randomizer is enabled by serially programming mode control register A1.

Digital Output Test Pattern

To allow in-circuit testing of the digital interface to the A/D, there is a test mode that forces the A/D data outputs (D13-D0) of all channels to known values. The digital output test patterns are enabled by serially programming mode control registers A3 and A4. When enabled, the test patterns override all other formatting modes: 2's complement and randomizer.

Output Disable

The digital outputs may be disabled by serially programming mode control register A2. The current drive for all digital outputs including DCO and FR are disabled to save power or enable in-circuit testing. When disabled the common mode of each output pair becomes high impedance, but the differential impedance may remain low.

Sleep and Nap Modes

The A/D may be placed in sleep or nap modes to conserve power. In sleep mode the entire chip is powered down, resulting in 1mW power consumption. Sleep mode is enabled by mode control register A1 (serial programming mode), or by SDI (parallel programming mode). The amount of time required to recover from sleep mode depends on the size of the bypass capacitors on V_{REF} , REFH, and REFL. For the suggested values in Figure 8, the A/D will stabilize after 2ms.

In nap mode any combination of A/D channels can be powered down while the internal reference circuits and the PLL stay active, allowing faster wakeup than from sleep



mode. Recovering from nap mode requires at least 100 clock cycles. If the application demands very accurate DC settling then an additional 50µs should be allowed so the on-chip references can settle from the slight temperature shift caused by the change in supply current as the A/D leaves nap mode. Nap mode is enabled by mode control register A1 in the serial programming mode.

DEVICE PROGRAMMING MODES

The operating modes of the LTC2175-14/LTC2174-14/ LTC2173-14 can be programmed by either a parallel interface or a simple serial interface. The serial interface has more flexibility and can program all available modes. The parallel interface is more limited and can only program some of the more commonly used modes.

Parallel Programming Mode

To use the parallel programming mode, PAR/SER should be tied to V_{DD} . The \overline{CS} , SCK, SDI and SDO pins are binary logic inputs that set certain operating modes. These pins can be tied to V_{DD} or ground, or driven by 1.8V, 2.5V, or 3.3V CMOS logic. When used as an input, SDO should be driven through a 1k series resistor. Table 3 shows the modes set by \overline{CS} , SCK, SDI and SDO.

Serial Programming Mode

To use the serial programming mode, PAR/SER should be tied to ground. The \overline{CS} , SCK, SDI and SDO pins become a serial interface that program the A/D mode control registers. Data is written to a register with a 16-bit serial word. Data can also be read back from a register to verify its contents.

Serial data transfer starts when \overline{CS} is taken low. The data on the SDI pin is latched at the first 16 rising edges of SCK. Any SCK rising edges after the first 16 are ignored. The data transfer ends when \overline{CS} is taken high again.

The first bit of the 16-bit input word is the R/\overline{W} bit. The next seven bits are the address of the register (A6:A0). The final eight bits are the register data (D7:D0).

If the R/\overline{W} bit is low, the serial data (D7:D0) will be written to the register set by the address bits (A6:A0). If the R/\overline{W} bit is high, data in the register set by the address bits (A6:A0) will be read back on the SDO pin (see the Timing Diagrams sections). During a read back command the register is not updated and data on SDI is ignored.

The SDO pin is an open-drain output that pulls to ground with a 200Ω impedance. If register data is read back through SDO, an external 2k pull-up resistor is required. If serial data is only written and read back is not needed,

Pin	DESCRIPTION					
CS	2-Lane / 1-Lane Selection Bit					
	0 = 2-Lane, 16-Bit Serialization Output Mode					
	1 = 1-Lane, 14-Bit Serialization Output Mode					
SCK	LVDS Current Selection Bit					
	0 = 3.5mA LVDS Current Mode					
	1 = 1.75mA LVDS Current Mode					
SDI	Power Down Control Bit					
	0 = Normal Operation					
	1 = Sleep Mode					
SDO	Internal Termination Selection Bit					
	0 = Internal Termination Disabled					
	1 = Internal Termination Enabled					

Table 3. Parallel Programming Mode Control Bits (PAR/ $\overline{\text{SER}}$ = V_{DD})



then SDO can be left floating and no pull-up resistor is needed. Table 4 shows a map of the mode control registers.

Software Reset

If serial programming is used, the mode control registers should be programmed as soon as possible after the power supplies turn on and are stable. The first serial command must be a software reset which will reset all register data bits to logic 0. To perform a software reset, bit D7 in the reset register is written with a logic 1. After the reset SPI write command is complete, bit D7 is automatically set back to zero.

GROUNDING AND BYPASSING

The LTC2175-14/LTC2174-14/LTC2173-14 requires a printed circuit board with a clean unbroken ground plane. A multilaver board with an internal ground plane in the first layer beneath the ADC is recommended. Layout for the printed circuit board should ensure that digital and analog signal lines are separated as much as possible. In particular, care should be taken not to run any digital track alongside an analog signal track or underneath the ADC.

Table 4. Serial Programming Mode Register Map (PAR/SER = GND)

High quality ceramic bypass capacitors should be used at the V_{DD}, OV_{DD}, V_{CM}, V_{RFF}, REFH and REFL pins. Bypass capacitors must be located as close to the pins as possible. Of particular importance is the 0.1µF capacitor between REFH and REFL. This capacitor should be on the same side of the circuit board as the A/D, and as close to the device as possible (1.5mm or less). Size 0402 ceramic capacitors are recommended. The larger 2.2µF capacitor between REFH and REFL can be somewhat further away. The traces connecting the pins and bypass capacitors must be kept short and should be made as wide as possible.

The analog inputs, encode signals, and digital outputs should not be routed next to each other. Ground fill and arounded vias should be used as barriers to isolate these signals from each other.

HEAT TRANSFER

Most of the heat generated by the LTC2175-14/LTC2174-14/ LTC2173-14 is transferred from the die through the bottomside Exposed Pad and package leads onto the printed circuit board. For good electrical and thermal performance, the Exposed Pad must be soldered to a large grounded pad on the PC board. This pad should be connected to the internal ground planes by an array of vias.

D7	D6	D5	D4	D3	D2	D1	D0
RESET	Х	Х	Х	Х	Х	Х	Х
Bit 7	RESET	Software Reset Bit		•			
		t. All Mode Control tically Set Back to Ze r is Write Only.	0		,	d in SLEEP Mode.	
Bits 6-0	Unused, Don't Care Bits.						
			ADDRESS 01h)				
REGISTER A1: F	URIMAI AND PUWER						
REGISTER A1: F D7	D6	D5	D4	D3	D2	D1	D0
D7 DCSOFF				D3 NAP_4	D2 NAP_3	D1 NAP_2	D0 NAP_1

		0110
Bit 6	RAND Data Output Randomizer Mode Control E	3it
	0 = Data Output Randomizer Mode Off	
	1 – Data Output Bandomizer Mode On	

i = Data Output Kandomizer Wode On



Bit 5	TWOSCOMP Two's Complement Mode Control Bit 0 = Offset Binary Data Format 1 = Two's Complement Data Format
Bits 4-0	SLEEP: NAP_4:NAP_1 Sleep/Nap Mode Control Bits 00000 = Normal Operation 0XXX1 = Channel 1 in Nap Mode 0XX1X = Channel 2 in Nap Mode 0X1XX = Channel 3 in Nap Mode 01XXX = Channel 4 in Nap Mode

1XXX = Channel 4 in Nap Mode 1XXXX = Sleep Mode. All Channels are Disabled Note: Any Combination of Channels Can Be Placed in Nap Mode.

REGISTER A2: OUTPUT MODE REGISTER (ADDRESS 02h)

		•	,				
D7	D6	D5	D4	D3	D2	D1	D0
ILVDS2	ILVDS1	ILVDS0	TERMON	OUTOFF	OUTMODE2	OUTMODE1	OUTMODE0
Bits 7-5	000 = 3.5mA LVDS 001 = 4.0mA LVDS 010 = 4.5mA LVDS 011 = Not Used 100 = 3.0mA LVDS 101 = 2.5mA LVDS 110 = 2.1mA LVDS	LVDS Output Currer 5 Output Driver Cur 5 Output Driver Cur 5 Output Driver Cur 6 Output Driver Cur 5 Output Driver Cur 6 Output Driver Cur 9 Output Driver Cur	rent rent rent rent rent rent				
Bit 4	TERMON LVDS Internal Termination Bit 0 = Internal Termination Off 1 = Internal Termination On. LVDS Output Driver Current is 2x the Current Set by ILVDS2:ILVDS0. Internal termination should only be used with 1.75mA, 2.1mA or 2.5mA LVDS output current modes.						ion should only be
Bit 3	OUTOFF Output Disable Bit 0 = Digital Outputs are Enabled. 1 = Digital Outputs are Disabled.						
Bits 2-0	OUTMODE2:OUTM 000 = 2-Lanes, 16 001 = 2-Lanes, 14 010 = 2-Lanes, 12 011 = Not Used 100 = Not Used 101 = 1-Lane, 14- 110 = 1-Lane, 12- 111 = 1-Lane, 16-	-Bit Serialization -Bit Serialization -Bit Serialization Bit Serialization Bit Serialization	tput Mode Control	Bits			
REGISTER A3: T	EST PATTERN MSB R	EGISTER (ADDRES	S 03h)				
D7	D6	D5	D4	D3	D2	D1	D0
OUTTEST	X	TP13	TP12	TP11	TP10	TP9	TP8

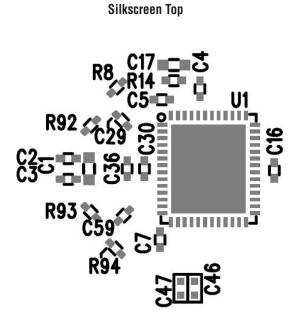
OUTTEST	Х	TP13	TP12	TP11	TP10	TP9	TP8
Bit 7	t 7 OUTTEST Digital Output Test Pattern Control Bit 0 = Digital Output Test Pattern Off 1 = Digital Output Test Pattern On						
Bit 6	Unused, Don't Care Bit.						
Bit 5-0	TP13:TP8 Test Pattern Data Bits (MSB) TP13:TP8 Set the Test Pattern for Data Bit 13(MSB) Through Data Bit 8.						
REGISTER A4: TEST PATTERN LSB REGISTER (ADDRESS 04h)							
D7	D6	D5	D4	D3	D2	D1	D0

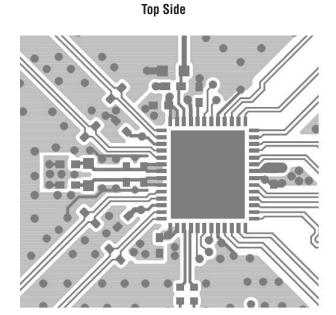
TP7 TP6 TP5 TP4 TP3 TP2 TP1 TP0 Bit 7-0 **TP7:TP0** Test Pattern Data Bits (LSB) Test Pattern Data Bits (LSB) Test Pattern Data Bits (LSB)

TP7:TP0 Set the Test Pattern for Data Bit 7 Through Data Bit 0(LSB).



TYPICAL APPLICATIONS

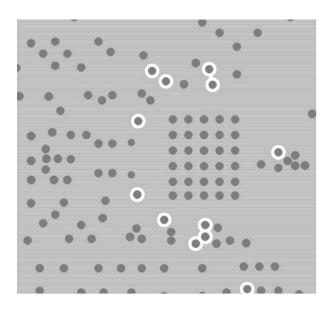




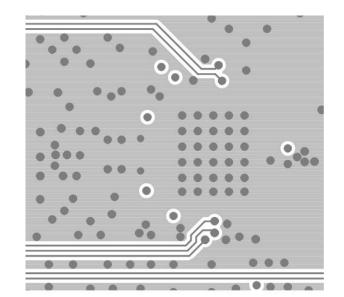




TYPICAL APPLICATIONS

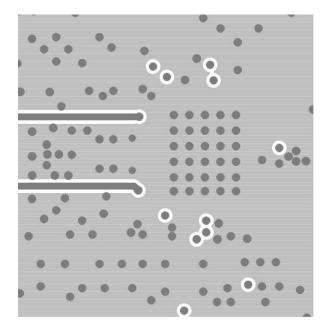


Inner Layer 2 GND

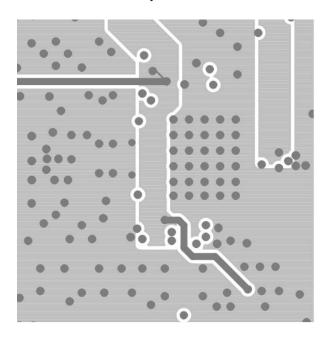


Inner Layer 3

Inner Layer 4



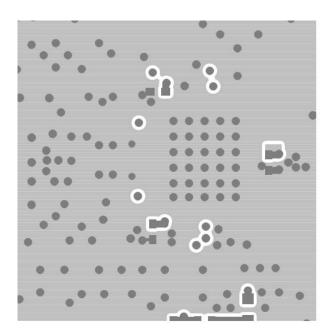
Inner Layer 5 Power





TYPICAL APPLICATIONS

Bottom Side



Silkscreen Bottom

C8 🗖

80

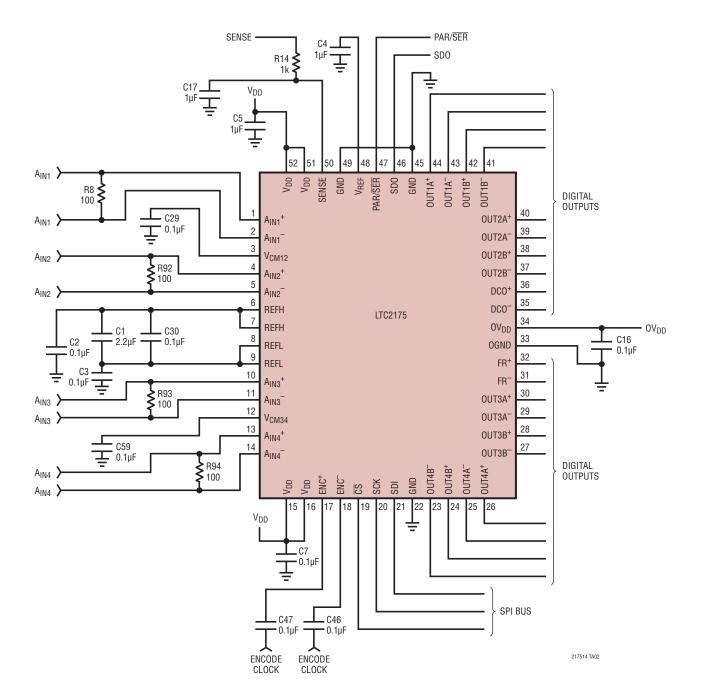
C15 🗖



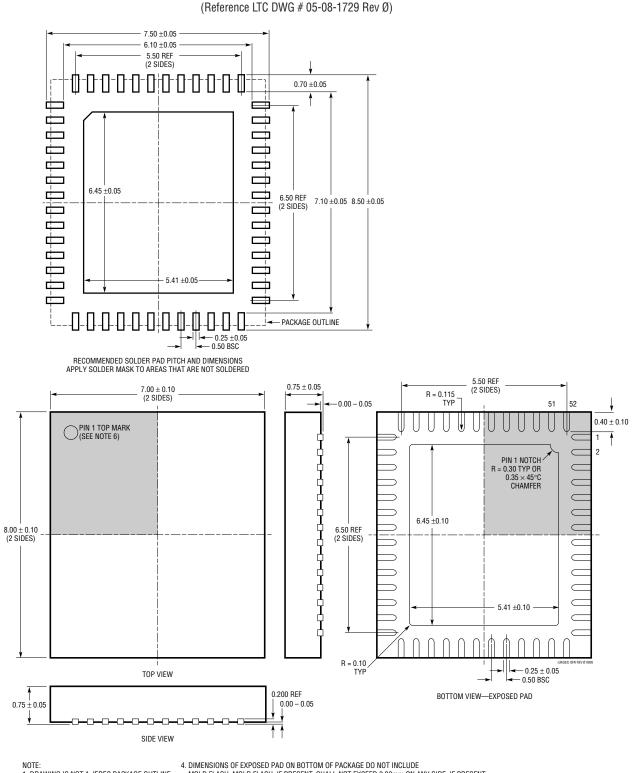
LTC2175-14/ LTC2174-14/LTC2173-14

TYPICAL APPLICATIONS

LTC2175 Schematic



PACKAGE DESCRIPTION



UKG Package 52-Lead Plastic QFN ($7mm \times 8mm$)

1. DRAWING IS NOT A JEDEC PACKAGE OUTLINE 2. DRAWING NOT TO SCALE 3. ALL DIMENSIONS ARE IN MILLIMETERS

MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.20mm ON ANY SIDE, IF PRESENT 5. EXPOSED PAD SHALL BE SOLDER PLATED

6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



REVISION HISTORY

REV	DATE	DESCRIPTION	PAGE NUMBER
А	6/11	Corrected part numbers in Description.	1
		Revised Software Reset paragraph and Table 4 in Applications Information section.	26
		Added V _{DD} to LTC2175 Schematic in Typical Applications section.	31





RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS
ADCs		
LTC2170-14/LTC2171-14/ LTC2172-14	14-Bit, 25Msps/40Msps/65Msps 1.8V Quad ADCs, Ultralow Power	178mW/234mW/360mW, 73.4dB SNR, 85dB SFDR, Serial LVDS Outputs, 7mm × 8mm QFN-52
LTC2170-12/LTC2171-12/ LTC2172-12	12-Bit, 25Msps/40Msps/65Msps 1.8V Quad ADCs, Ultralow Power	178mW/234mW/360mW, 70.5dB SNR, 85dB SFDR, Serial LVDS Outputs, 7mm × 8mm QFN-52
LTC2173-12/LTC2174-12/ LTC2175-12	12-Bit, 80Msps/105Msps/125Msps 1.8V Quad ADCs, Ultralow Power	412mW/481mW/567mW, 70.5dB SNR, 85dB SFDR, Serial LVDS Outputs, 7mm × 8mm QFN-52
LTC2256-14/LTC2257-14/ LTC2258-14	14-Bit, 25Msps/40Msps/65Msps Msps1.8V ADCs, Ultralow Power	35mW/49mW/81mW, 74dB SNR, 88dB SFDR, DDR LVDS/DDR CMOS/CMOS Outputs, 6mm × 6mm QFN-36
LTC2259-14/LTC2260-14/ LTC2261-14	14-Bit, 80Msps/105Msps/125Msps 1.8V ADCs, Ultralow Power	89mW/106mW/127mW, 73.4dB SNR, 85dB SFDR, DDR LVDS/DDR CMOS/CMOS Outputs, 6mm × 6mm QFN-36
LTC2262-14	14-Bit, 150Msps 1.8V ADC, Ultralow Power	149mW, 72.8dB SNR, 88dB SFDR, DDR LVDS/DDR CMOS/CMOS Outputs, 6mm × 6mm QFN-36
LTC2263-14/LTC2264-14/ LTC2265-14	14-Bit, 25Msps/40Msps/65Msps 1.8V Dual ADCs, Ultralow Power	99mW/126mW/191mW, 73.4dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36
LTC2263-12/LTC2264-12/ LTC2265-12	12-Bit, 25Msps/40Msps/65Msps 1.8V Dual ADCs, Ultralow Power	99mW/126mW/191mW, 70.5dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36
LTC2266-14/LTC2267-14/ LTC2268-14	14-Bit, 80Msps/105Msps/125Msps 1.8V Dual ADCs, Ultralow Power	216mW/250mW/293mW, 73.4dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36
LTC2266-12/LTC2267-12/ LTC2268-12	12-Bit, 80Msps/105Msps/125Msps 1.8V Dual ADCs, Ultralow Power	216mW/250mW/293mW, 70.5dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36
RF Mixers/Demodulators		
LTC5517	40MHz to 900MHz Direct Conversion Quadrature Demodulator	High IIP3: 21dBm at 800MHz, Integrated LO Quadrature Generator
LTC5527	400MHz to 3.7GHz High Linearity Downconverting Mixer	24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50 Ω Single-Ended RF and LO Ports
LTC5557	400MHz to 3.8GHz High Linearity Downconverting Mixer	23.7dBm IIP3 at 2.6GHz, 23.5dBm IIP3 at 3.5GHz, NF = 13.2dB, 3.3V Supply Operation, Integrated Transformer
LTC5575	800MHz to 2.7GHz Direct Conversion Quadrature Demodulator	High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated RF and LO Transformer
Amplifiers/Filters	<u>^</u>	
LTC6412	800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier	Continuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Figure, 4mm × 4mm QFN-24
LTC6420-20	1.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF	Fixed Gain 10V/V, 1nV/ $\sqrt{\text{Hz}}$ Total Input Noise, 80mA Supply Current per Amplifier, 3mm \times 4mm QFN-20
LTC6421-20	1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers	Fixed Gain 10V/V, 1nV/ $\sqrt{\text{Hz}}$ Total Input Noise, 40mA Supply Current per Amplifier, 3mm \times 4mm QFN-20
LTC6605-7/ LTC6605-10/ LTC6605-14	Dual Matched 7MHz/10MHz/14MHz Filters with ADC Drivers	Dual Matched 2nd Order Lowpass Filters with Differential Drivers, Pin-Programmable Gain, 6mm × 3mm DFN-22
LTM9002	14-Bit Dual Channel IF/Baseband Receiver Subsystem	Integrated High Speed ADC, Passive Filters and Fixed Gain Differential Amplifiers

